

<b>Notice of References Cited</b>	Application/Control No. 10/769,820	Applicant(s)/Patent Under Reexamination TANAKA, KOICHIRO	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,724,222	02-1988	Feldman, Martin	250/492.2
*	B	US-5,907,770	05-1999	Yamazaki et al.	438/149
*	C	US-2002/0162630	11-2002	Satoh et al.	156/345.51
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP405042337A	02-1993	Japan	Amada co ltd	
	O	JP410116801A	05-1998	Japan	Rohm co ltd	
	P	JP361067586A	04-1986	Japan	Furukawa Electric co ltd	
	Q	JP402122017A	05-1990	Japan	Toshiba corp	
	R	JP403032482A	02-1991	Japan	Fanuc ltd	
	S	JP403184756A	08-1991	Japan	Fuji Electric co ltd	
	T	JP05211118A	08-1993	Japan	Ricoh KK	

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Derwent-Acc-No: 1998-465889; Derwent-Week: 199841; Copyright 2006; Patent Family Pub No. RU 2105381 C1, Feb 20, 1998; "Processing of silicon chips - includes preliminary bending of chip and annealing ... chip bent into concave form; 1 sheet.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP407323384A	12-1995	Japan	Souei Tsusho KK	
	O	JP410071483A	03-1998	Japan	Hitachi Constr Mach co	
	P	JP02000317662A	11-2000	Japan	Ricoh co ltd	
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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